## In the Claims:

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1. (Currently Amended) An in-plane switching mode LCD device comprising:

first and second substrates;

data and gate lines on the first substrate to define a plurality of pixel regions;

at least one data electrode on the first substrate;

at least one common electrode on the first substrate;

a transparent conductive film in a layer over the data electrode, the transparent conductive film electrically connected with the common electrode; and

a liquid crystal layer between the first and second substrates.

- 2. (Original) The device of claim 1, wherein the transparent conductive film includes indium tin oxide (ITO).
- 3. (Original) The device of claim 1, further comprising a gate insulating film on the common electrode.
- 4. (Original) The device of claim 1, further comprising a passivation film on the common electrode.
- 5. (Original) The device of claim 4, wherein the common electrode is electrically connected with the transparent conductive film through a contact hole in the passivation film.
- 6. (Original) The device of claim 1, wherein the common electrode is electrically connected with the transparent conductive film through a laser welding.
- 7. (Original) The device of claim 1, wherein the liquid crystal layer includes a cyano (CN) based liquid crystal.

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8. (Original) The device of claim 1, wherein the liquid crystal layer includes a fluorine (F) based liquid crystal.

- 9. (Original) The device of claim 1, wherein the transparent conductive film is formed outermost to the common electrode.
- 10. (Original) The device of claim 1, wherein the transparent conductive film extends toward the data electrode.

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11. (Currently Amended) A method for manufacturing an in-plane switching mode LCD device comprising:

providing first and second substrates;

forming a plurality of gate lines and common electrodes on the first substrate;

forming a gate insulating film on the common electrodes;

forming a plurality of data lines and data electrodes on the gate insulating film;

forming a transparent conductive film in a layer over the data electrode, the

transparent conductive film electrically connected with the common electrodes; and

forming a liquid crystal layer between the first and second substrates.

- 12. (Original) The method of claim 11, wherein the common electrode is selected from the group of consisting of Al, Cr, Ti and Al alloy.
- 13. (Original) The method of claim 11, further comprising the step of forming a passivation film on the data electrodes.
- 14. (Original) The method of claim 11, wherein the common electrode is electrically connected with the transparent conductive film through a contact hole of the passivation film.

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- 15. (Original) The method of claim 11, further comprising the step of electrically connecting the common electrodes with the transparent conductive film.
- 16. (Original) The method of claim 15, wherein the common electrode is electrically connected with the transparent conductive film through a laser welding.
- 17. (Original) The method of claim 11, wherein the transparent conductive film includes indium tin oxide (ITO).
- 18. (Original) The method of claim 11, wherein the liquid crystal layer includes a cyano (CN) based liquid crystal.
- 19. (Original) The method of claim 1 k, wherein the liquid crystal layer includes a fluorine (F) based liquid crystal.
- 20. (Original) The method of claim 11, wherein the transparent conductive film is formed outmost to the common electrodes.
- 21. (Original) The method of claim 11, wherein the transparent conductive film extends toward at least one of the data electrodes.